

SEMITRANS[®] 2

Trench IGBT Modules

SKM 75GB176D

Features

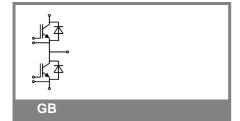
- Homogeneous Si
- Trench = Trenchgate technology
- V_{CE(sat)} with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I_C

Typical Applications*

- AC inverter drives mains 575 -750 V AC
- Public transport (auxiliary syst.)

Absolute Maximum Ratings T _{case} = 25°C, unless otherwise specified							
Symbol	Conditions	Values	Units				
IGBT							
V_{CES}	T _j = 25 °C	1700	V				
I _C	$T_j = 150 ^{\circ}\text{C}$ $T_c = 25 ^{\circ}\text{C}$	80	Α				
	T _c = 80 °C	55	Α				
I _{CRM}	I _{CRM} =2xI _{Cnom}	100	Α				
V_{GES}		± 20	V				
t _{psc}	$V_{CC} = 1200 \text{ V}; V_{GE} \le 20 \text{ V}; T_j = 125 \text{ °C}$	10	μs				
	V _{CES} < 1700 V						
Inverse D	iode						
I _F	$T_j = 150 ^{\circ}\text{C}$ $T_c = 25 ^{\circ}\text{C}$	80	Α				
	T _c = 80 °C	55	Α				
I _{FRM}	I _{FRM} =2xI _{Fnom}	100	Α				
I _{FSM}	$t_p = 10 \text{ ms; sin.}$ $T_j = 150 \text{ °C}$	550	Α				
Module							
$I_{t(RMS)}$		200	Α				
T _{vj}		-40 + 150	°C				
T _{stg}		-40 + 125	°C				
V _{isol}	AC, 1 min.	4000	V				

Characteristics T _{case} =		25°C, unless otherwise specified				
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
$V_{\text{GE(th)}}$	$V_{GE} = V_{CE}$, $I_C = 2 \text{ mA}$		5,2	5,8	6,4	V
I _{CES}	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T _j = 25 °C			3	mA
V _{CE0}		T _j = 25 °C		1	1,2	V
		T _j = 125 °C		0,9	1,1	V
r _{CE}	V _{GE} = 15 V	T _j = 25°C		20	25	mΩ
		T _j = 125°C		31	36	mΩ
V _{CE(sat)}	I _{Cnom} = 50 A, V _{GE} = 15 V			2	2,45	V
		$T_j = 125^{\circ}C_{chiplev.}$		2,45	2,9	V
C _{ies}				4,3		nF
C _{oes}	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,18		nF
C _{res}				0,15		nF
Q_G	V _{GE} = -8V+15V			410		nC
R_{Gint}	T _j = 25 °C			9,5		Ω
$t_{d(on)}$				210		ns
t _r	R_{Gon} = 6,2 Ω	V _{CC} = 1200V		30		ns
Ė _{on}	di/dt = 1680 A/μs	I _C = 50A		25		mJ
^L d(off)	$R_{Goff} = 6.2 \Omega$	T _j = 125 °C		590		ns
t _f	di/dt = 320 A/µs	V _{GE} = ±15V		135		ns
E _{off}				18		mJ
$R_{th(j-c)}$	per IGBT				0,38	K/W





Trench IGBT Modules

SKM 75GB176D

Features

- Homogeneous Si
- Trench = Trenchgate technology
- V_{CE(sat)} with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I_C

Typical Applications*

- AC inverter drives mains 575 -750 V AC
- Public transport (auxiliary syst.)

Characteristics						
Symbol	Conditions		min.	typ.	max.	Units
Inverse Diode						
$V_F = V_{EC}$	I_{Fnom} = 50 A; V_{GE} = 0 V			1,7	1,9	V
		T _j = 125 °C _{chiplev.}		1,8	2	V
V _{F0}		T _j = 25 °C		1,1	1,3	V
		T _j = 125 °C		0,9	1,1	V
r _F		T _j = 25 °C		12	12	mΩ
		T _j = 125 °C		18	18	mΩ
I _{RRM}	I _F = 50 A	T _j = 125 °C		52		Α
Q_{rr}	di/dt = 1320 A/µs			20		μC
E _{rr}	$V_{GE} = -15 \text{ V}; V_{CC} = 1200 \text{ Y}$	V		14,5		mJ
$R_{th(j-c)D}$	per diode				0,55	K/W
Module						
L _{CE}					30	nΗ
R _{CC'+EE'}	res., terminal-chip	T _{case} = 25 °C		0,75		mΩ
		T _{case} = 125 °C		1		mΩ
R _{th(c-s)}	per module				0,05	K/W
M _s	to heat sink M6		3		5	Nm
M _t	to terminals M5		2,5		5	Nm
w					160	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.





SEMITRANS[®] 2

Trench IGBT Modules

SKM 75GB176D

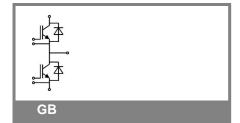
Features

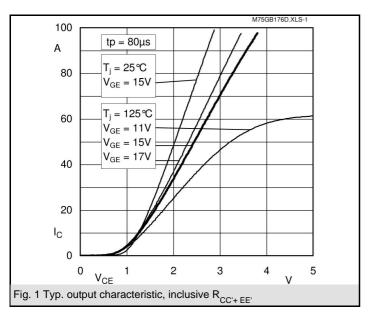
- Homogeneous Si
- Trench = Trenchgate technology
- V_{CE(sat)} with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I_C

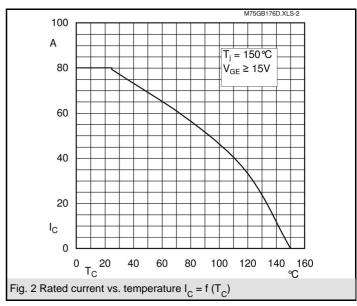
Typical Applications*

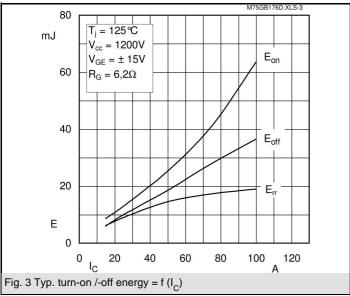
- AC inverter drives mains 575 -750 V AC
- Public transport (auxiliary syst.)

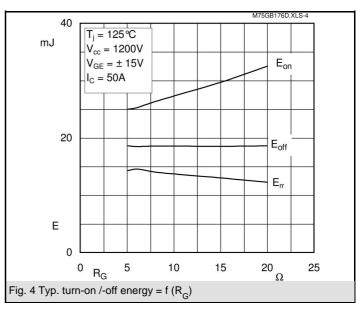
Z _{th} Symbol	Conditions	Values	Units
Z,,,,,,,,,,			•
Z R _i	i = 1	270	mk/W
R _i	i = 2	85	mk/W
Ri	i = 3	21	mk/W
R _i	i = 4	4	mk/W
tau _i	i = 1	0,0393	s
tau _i	i = 2	0,0786	s
tau _i	i = 3	0,0014	s
tau _i	i = 4	0,0002	s
Z _{th(j-c)D}			·
R _i	i = 1	360	mk/W
Ri	i = 2	150	mk/W
R_{i}	i = 3	36	mk/W
R _i	i = 4	4	mk/W
tau _i	i = 1	0,0262	s
tau _i	i = 2	0,0417	s
tau _i	i = 3	0,0012	s
tau _i	i = 4	0,001	s

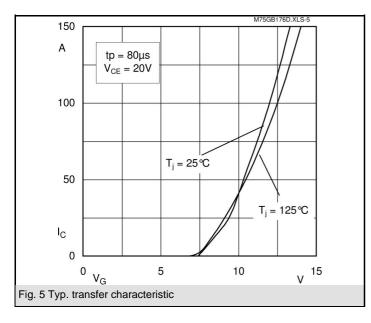


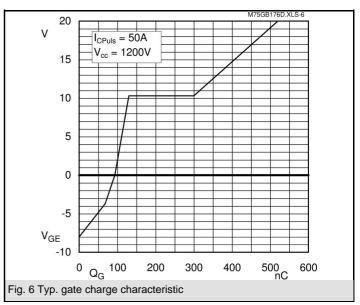


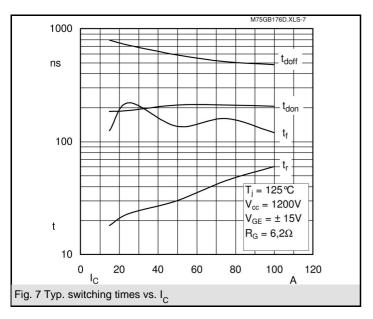


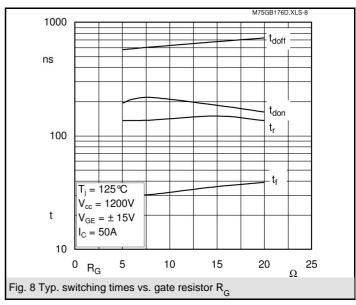


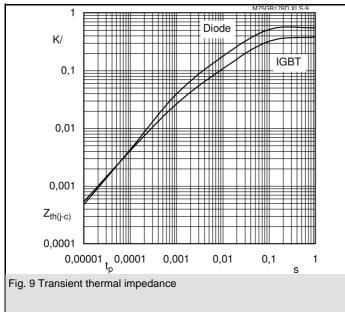


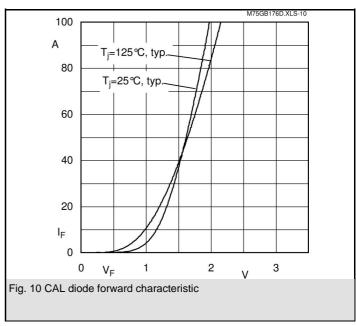


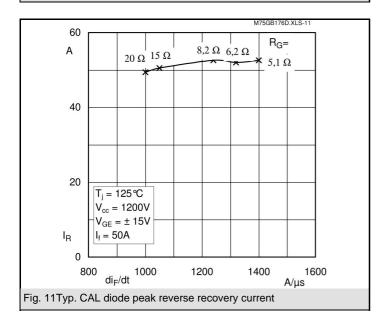


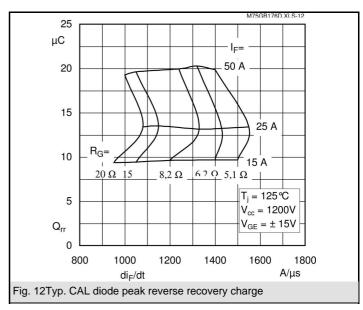


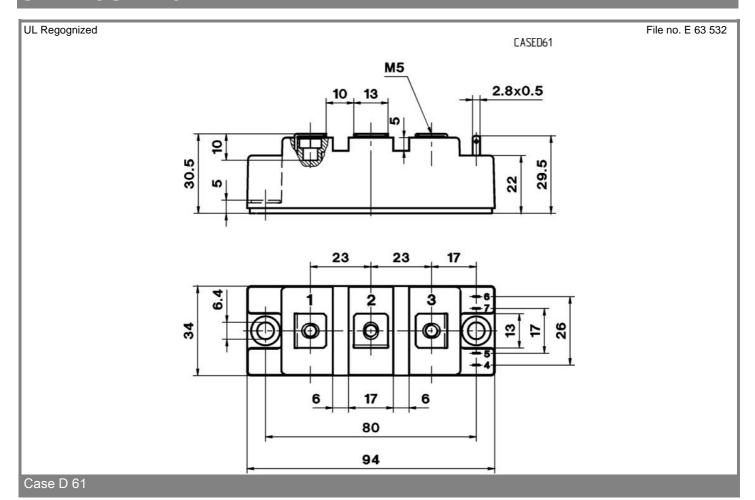


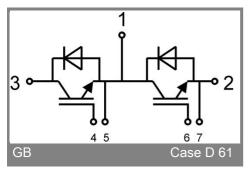












6 28-06-2010 GIL © by SEMIKRON